

Search Notes

Application/Control No.

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Examiner

Susan Y. Chen

Applicant(s)/Patent under
Reexamination

WEAVER ET AL.

Art Unit

2161

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated text search on East DB for classes/subclasses: 707/5; 706/45; 709/220; 717/110	2/9/2007	TYC
NPL: IEEE keywords search	2/9/2007	TYC